Product data sheet

1. General description

Silicon Carbide MOSFET in a TSPAK plastic package with top side cooling structure, designed for high frequency, high efficiency systems.



2. Features and benefits

- Automotive Qualified (AEC-Q101)
- · Reduced cooling requirements
- Low on-resistance
- Fast switching speed
- · 0V turn-off gate voltage for simple gate driver
- 100% UIS Tested
- Easy to parallel
- Controllable dV/dt for optimized EMI
- RoHS compliant



3. Applications

- Automotive on board chargers
- Automotive DC-DC converters
- · Automotive electric compressor motor drives
- HV battery management systems

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values		Unit	
Absolute	maximum rating						
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C			1200		V
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C			134		Α
P _{tot}	total power dissipation	T _{mb} = 25 °C, T _j = 175 °C			592		W
T _j	junction temperature			-55 to 175		°C	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
$R_{\text{DS(on)}}$	drain-source on-state resistance	$V_{GS} = 15 \text{ V}; I_D = 50 \text{ A}; T_j = 25 ^{\circ}\text{C}$		-	20	-	mΩ
		V _{GS} = 18 V; I _D = 50 A; T _j = 25 °C		-	16.3	29	mΩ
Dynamic	characteristics		·				
Q _{G(tot)}	total gate charge	$I_D = 50 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	215	-	nC
Q_{GD}	gate-drain charge	T _j = 25 °C		-	32	-	nC
Source-d	rain diode						
Q _r	recovered charge	I_{SD} = 50 A; di/dt = 500 A/µs; V_{DS} = 400 V; T_i = 25 °C		-	276	-	nC

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol			
1	G	gate	9	D			
2	SS	source sense					
3-7	S	source	1	$G \longrightarrow A$			
8-9 mb	D	mounting base; connected to drain	7 6 5 4 3 2 1	SS Sym301 S			

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity		Package issue date
WNSC2M20120TB-A	TSPAK	WNSC2M20120TB-A6J	Reel	600	TSPAKH	06-Dec-2024

7. Marking

Table 4. Marking codes

Type number	Marking codes
WNSC2M20120TB-A	WNSC2M 20120TB-A

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		1200	V
$V_{\rm GS,max}$	gate-source voltage	Absolute maximum values		-10 to 22	V
$V_{GS,op}$	gate-source voltage	Recommended operational values		-4 to 18	V
P _{tot}	total power dissipation	T _{mb} = 25 °C, T _j = 175 °C		592	W
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C		134	Α
		V _{GS} = 18 V; T _{mb} = 100 °C		94.5	Α
I _{DM}	peak drain current	pulse width t _p limited by T _{jmax}	Fig.17	260	А
Is	continuous diode current	V _{GS} = -4 V; T _{mb} = 25 °C		86.1	А
I _{SM}	pulse diode current	V_{GS} = -4 V; pulse width t_p limited by T_{jmax}		260	А
E _{as}	single pulse drain-to- source avalanche	$I_{AS} = 30 \text{ A}; L = 1 \text{ mH}; V_{DD} = 100 \text{ V};$ $T_j = 25 \text{ °C}$		450	mJ
T _{stg}	storage temperature			-55 to 175	°C
T _j	junction temperature			-55 to 175	°C
$T_{sld(M)}$	peak soldering temperature			260	°C

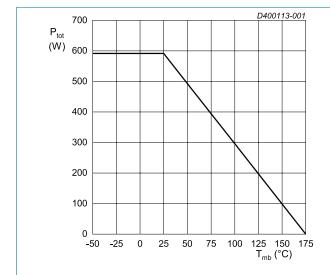


Fig. 1. Total power dissipation as a function of mounting base temperature; maximum values

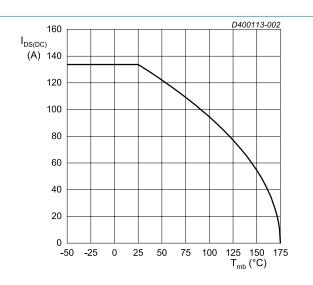


Fig. 2. Continuous Drain Current as a function of mounting base temperature

9. Thermal & Mechanical characteristics

Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base			-	0.25	-	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W

Note: Device is ESD sensitive. Handling precautions are recommended.

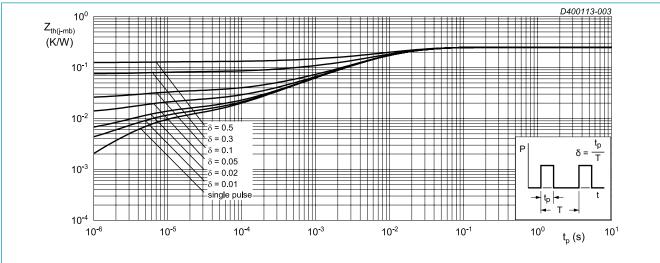


Fig. 3. Transient thermal impedance from junction to mounting base as a function of pulse duration

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 100 \mu A; V_{GS} = 0 V; T_j = 25 ^{\circ}C$		1200	-	-	V
$V_{\text{GS(th)}}$	gate-source threshold	$I_D = 20 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C}$		1.9	2.6	3.5	V
	voltage	$I_D = 20 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 175 \text{ °C}$		-	1.9	-	V
I _{DSS}	drain leakage current	$V_{DS} = 1200 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	0.2	100	μA
		V _{DS} = 1200 V; V _{GS} = 0 V; T _j = 175 °C		-	2	-	μA
I _{GSS}	gate leakage current	$V_{GS} = 22 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	10	100	nA
		$V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	10	100	nA
R _{DS(on)}	drain-source on-state	V _{GS} = 15 V; I _D = 50 A; T _j = 25 °C		-	20	-	mΩ
	resistance	V _{GS} = 18 V; I _D = 50 A; T _j = 25 °C		-	16.3	29	mΩ
		V _{GS} = 18 V; I _D = 50 A; T _j = 175 °C		-	27.6	-	mΩ
R _G	gate resistance	f = 1 MHz; T _j = 25 °C		-	0.6	-	Ω
g _{fs}	transconductance	$V_{DS} = 20 \text{ V}; I_D = 50 \text{ A}; T_j = 25 \text{ °C}$		-	32	-	S
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_D = 50 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	215	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C		-	83	-	nC
Q_{GD}	gate-drain charge			-	32	-	nC
C _{iss}	input capacitance	$V_{DS} = 1000 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$ $T_j = 25 \text{ °C}$		-	4701	-	pF
C _{oss}	output capacitance			-	199	-	pF
C _{rss}	reverse transfer capacitance			-	20	-	pF
E _{oss}	Coss stored energy			-	100	-	μJ
t _{d(on)}	turn-on delay time	$V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V}; R_{G(ext)} = 5.1$		-	32	-	ns
t _r	rise time	$Ω$; $I_D = 50 \text{ A}$; $L = 100 \mu\text{H}$; $T_j = 25 \degree \text{C}$		-	38	-	ns
$t_{d(off)}$	turn-off delay time			-	67	-	ns
t _f	fall time			-	16	-	ns
E _{on}	turn-on energy (SIC Diode FWD)		Fig.20	-	653	-	μJ
E _{off}	turn-off energy (SIC Diode FWD)		Fig.20	-	347	-	μJ
E _{on}	turn-on energy (Body Diode FWD)		Fig.20	-	800	-	μJ
E _{off}	turn-off energy (Body Diode FWD)		Fig.20	-	324	-	μJ
Source-d	rain diode					<u>'</u>	,
V _{SD}	source-drain voltage	V _{GS} = 0 V; I _{SD} = 25 A; T _j = 25 °C		-	3.2	-	V
		V _{GS} = -4 V; I _{SD} = 25 A; T _j = 25 °C		-	4.8	-	V
		$V_{GS} = -4 \text{ V}; I_{SD} = 25 \text{ A}; T_j = 175 \text{ °C}$		-	4.2	-	V
t _{rr}	reverse recovery time	$I_{SD} = 50 \text{ A}$; di/dt = 500 A/ μ s; $V_{DS} = 400 \text{ V}$;		-	54	-	ns
Q_r	recovered charge	T _j = 25 °C		-	276	-	nC
I _{rrm}	reverse recovery current			-	9	-	Α

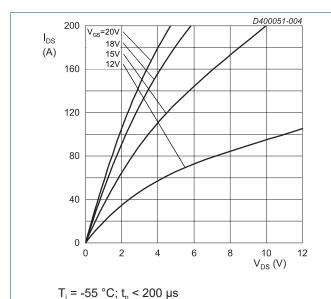


Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values

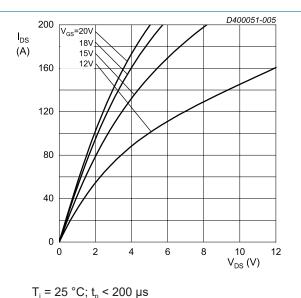
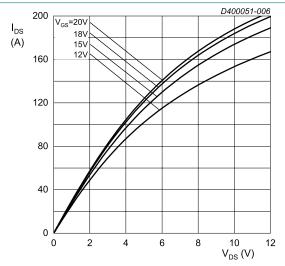
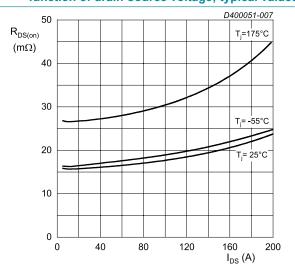


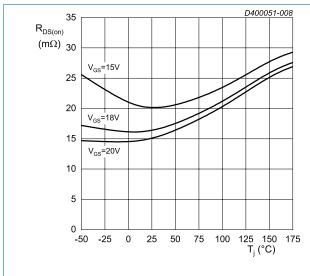
Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



 $T_{j}=175~^{\circ}C;~t_{p}<200~\mu s$ Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

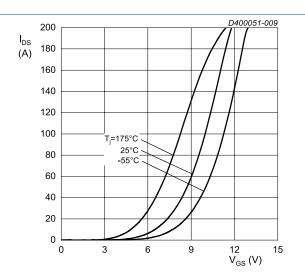


 V_{GS} = 18 V; t_p < 200 µs Fig. 7. Drain-source on-state resistance as a function of drain current; typical values



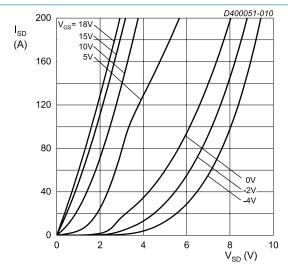
 I_{DS} = 50 A; t_p < 200 μ s

Fig. 8. Drain-source on-state resistance as a function of junction temperature



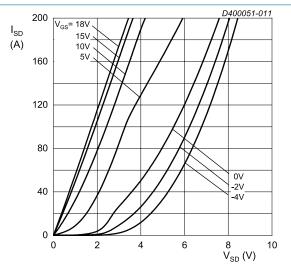
 V_{DS} = 20 V; t_p < 200 μ s

Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values



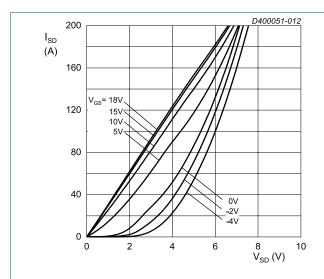
 $T_{\rm j}$ = -55 °C; $t_{\rm p}$ < 200 µs

Fig. 10. Body diode forward characteristics; typical values



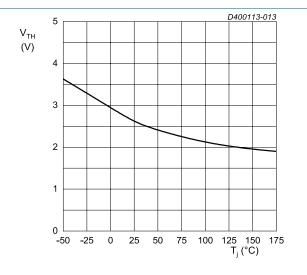
 $T_i = 25 \,^{\circ}\text{C}; t_p < 200 \,\mu\text{s}$

Fig. 11. Body diode forward characteristics; typical values

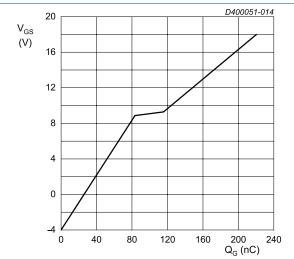


 $T_j = 175 \,^{\circ}\text{C}; t_p < 200 \,\mu\text{s}$

Fig. 12. Body diode forward characteristics; typical values



V_{DS} = 10 V; I_{DS} = 20 mA Fig. 13. Threshold voltage as a function of junction temperature



I_{DS} = 50 A; I_{GS} = 0.1 mA; V_{DS} = 800 V; T_j = 25 °C Fig. 14. Gate-source voltage as a function of gate charge; typical values

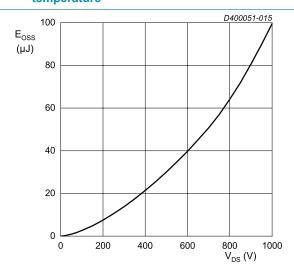
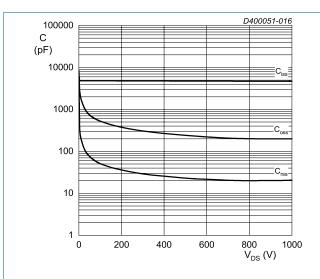


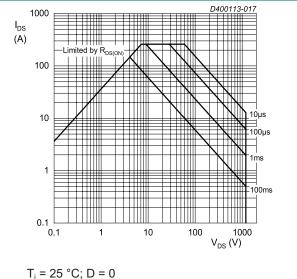
Fig. 15. Output capacitor stored energy as a function of drain-source voltage



 $V_{DS} = 0 - 1000 V$

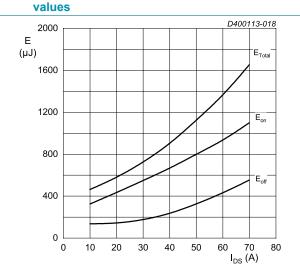
 $T_j = 25 \, ^{\circ}C; \, V_{AC} = 25 \, \text{mV}; \, f = 1 \, \text{MHz}$

Fig. 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical



Parameter: t₀

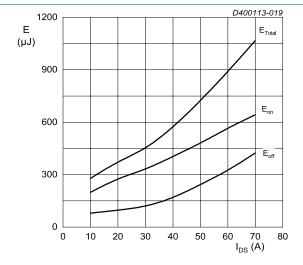
Fig. 17. Forward bias safe operating area



$$\begin{split} T_{j} = 25~^{\circ}\text{C}; \ V_{DD} = 800 \ V; \ R_{G(ext)} = 5.1 \ \Omega; \\ V_{GS} = -4 \ V/18 \ V; \ L = 100 \ \mu H \end{split}$$

FWD = WNSC2M20120TB-A

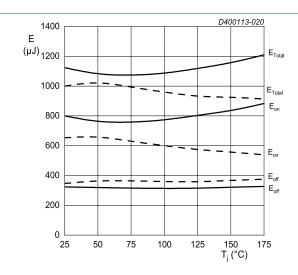
Fig. 18. Clamped Inductive Switching Energy as a function of drain current



 T_{j} = 25 °C; V_{DD} = 600 V; $R_{G(ext)}$ = 5.1 $\Omega;$ V_{GS} = -4 V/18 V; L = 100 μH

FWD = WNSC2M20120TB-A

Fig. 19. Clamped Inductive Switching Energy as a function of drain current

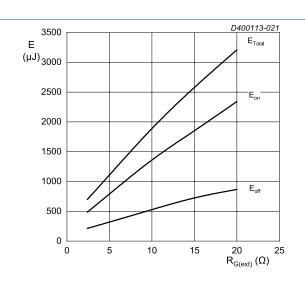


 $I_{DS}=50$ A; $V_{DD}=800$ V; $R_{G(ext)}=5.1~\Omega;$ $V_{GS}=-4$ V/18 V; $L=100~\mu H$

FWD = WNSC2M20120TB-A

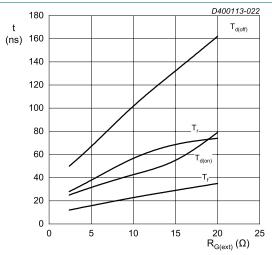
FWD = WNSC2D401200TB(---)

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



 T_{j} = 25 °C; V_{DD} = 800 V; I_{DS} = 50 A; V_{GS} = -4 V/18 V FWD = WNSC2M20120TB-A; L = 100 μH

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



 T_{i} = 25 °C; V_{DD} = 800 V; I_{DS} = 50 A; V_{GS} = -4 V/18 V FWD = WNSC2M20120TB-A; L = 100 μH

Fig. 22. Switching time as a function of external gate resistance

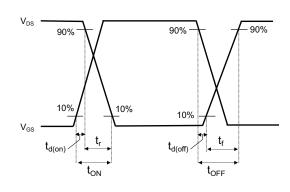
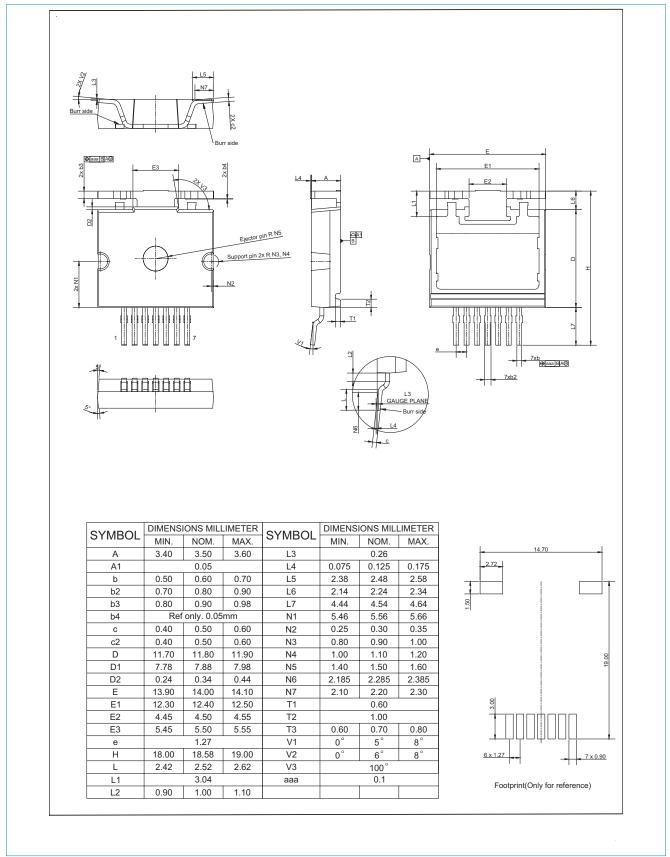


Fig. 23. Switching time definition

11. Package outline



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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13. Contents

1. General description	1
2. Features and benefits	1
3. Applications	1
4. Quick reference data	1
5. Pinning information	2
6. Ordering information	2
7. Marking	2
8. Limiting values	3
9. Thermal & Mechanical characteristics	4
10. Characteristics	5
11. Package outline	11
12. Legal information	12
13. Contents	14

For more information, please visit: http://www.ween-semi.com For sales office addresses, please send an email to: salesaddresses@ween-semi.com Date of release: 08 May 2025

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